

**Search Notes**

Application/Control No.

10/760,651

Examiner

RAYMOND PHAN

Applicant(s)/Patent under  
Reexamination

TIERNEY ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	309-315, 105-107, 110-112	2/12/2008	RP
711	136-146	2/12/2008	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
711	141,146	2/15/2008	RP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR